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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977-029003	Application No OIPE 09/816,492
Information Disclosure Statement by Applicant		Applicant Hongyong Zhang	SEP 2 9 2003
	heets if necessary)	Filing Date March 23, 2001	Group Art Unit 2871

			U.S. Patent	Documents			
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
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	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Trans	ation
Initial	_ID ¯	Number	Date	Patent Office	Class	Subclass	Yes	No
11	AL	05-181159	07/23/1993	JAPAN			Full	
1	AM	06-011728	01/21/1994	JAPAN			Full	
	AN	07-248507	09/26/1995	JAPAN			Full	_
	AO							
	AP							

	Other Documents (include Author, Title, Date, and Place of Publication)						
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U.S Department of Commerce Setent and Trademark Office Attorney's Docket No. Application No. Substitute Form PTO 449 (Modified) 07977-029003 09/816,492 Information Disclosure Statement by Applicant (Use several sheets if necessary) Applicant Hongyong Zhang

(37 CFR §1.98(b))

	U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate	
17	AA	5,339,181	08/16/1994	Kim et al.				
	AB							
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March 23, 2001

	Foreign Patent Documents or Published Foreign Patent Applications								
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4	AL	05-181159	07/23/1993	JAPAN			ABS		
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	AP								

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